Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
09/356,505	TAKEO, HIDEYA	
Examiner	Art Unit	
Anand Bhatnagar	2623	

SEARCHED					
Class	Subclass	Date	Examiner		
382	2321-253	8/26/2005	АВ		
text	see sheet	8/26/2005	AB		
updated	see sheet	8/26/2005	AB		
		•			

INTERFERENCE SEARCHED						
Class	Subclass	Date	Examiner			
SOD I	terfere,	cesh	c'AB			
Sparch	Printo	ut A)			
		9/2/05	7			

SEARCH NOTES (INCLUDING SEARCH STRATEGY)					
	DATE	EXMR			
east	8/26/2005	AB			
ToA	s/16/05				
Interference Scarch (quant #8 and (encod#4 ad#5) and classifi#8)	. 8/26/25 .clm.	AB			
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